


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576806	<b>Applicant(s)/Patent Under Reexamination</b>  EONNET, YVES
	<b>Examiner</b>  MARCOS BATISTA	<b>Art Unit</b>  4134

SEARCHED			
Class	Subclass	Date	Examiner
455	411	3/4/2008	mb
726	27	2/4/2008	mb

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Steve D'Agosta	3/4/2008	mb
Consulted with TA - Yogesh Aggarwal	3/4/2008	mb
Consulted with Lun-YI Lao	3/4/2008	mb
East Search	3/4/2008	mb
Inventor's Name Seach	3/4/2008	mb
Rafael Perez Gutierrez	3/4/2008	mb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner